

Symbol	Parameter		FQD3P50 / FQU3P50	Units
V _{DSS}	Drain-Source Voltage		-500	V
I _D	Drain Current - Continuous (T _C = 25°C	:)	-2.1	А
	- Continuous (T _C = 100°	C)	-1.33	А
I _{DM}	Drain Current - Pulsed	(Note 1)	-8.4	А
V _{GSS}	Gate-Source Voltage		± 30	V
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	250	mJ
I _{AR}	Avalanche Current	(Note 1)	-2.1	А
E _{AR}	Repetitive Avalanche Energy	(Note 1)	5.0	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	-4.5	V/ns
P _D	Power Dissipation (T _A = 25°C) *		2.5	W
	Power Dissipation (T _C = 25°C) - Derate above 25°C		50	W
			0.4	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +150	°C
ΤL	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

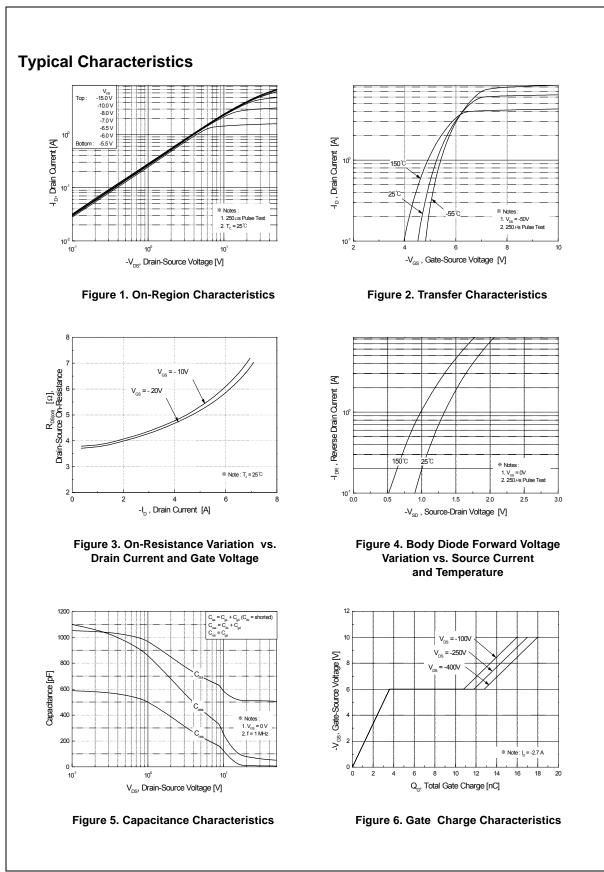
Thermal Characteristics

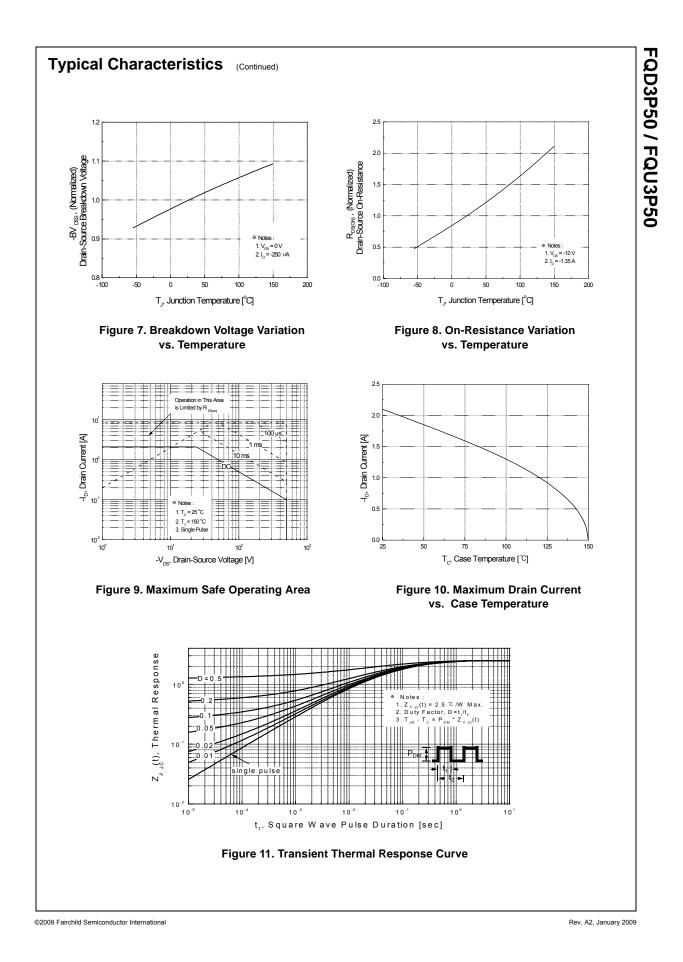
Symbol	Parameter	Тур	Max	Units
R _{θJC}	Thermal Resistance, Junction-to-Case		2.5	°C/W
R _{θJA}	Thermal Resistance, Junction-to-Ambient *		50	°C/W
R _{θJA}	Thermal Resistance, Junction-to-Ambient		110	°C/W

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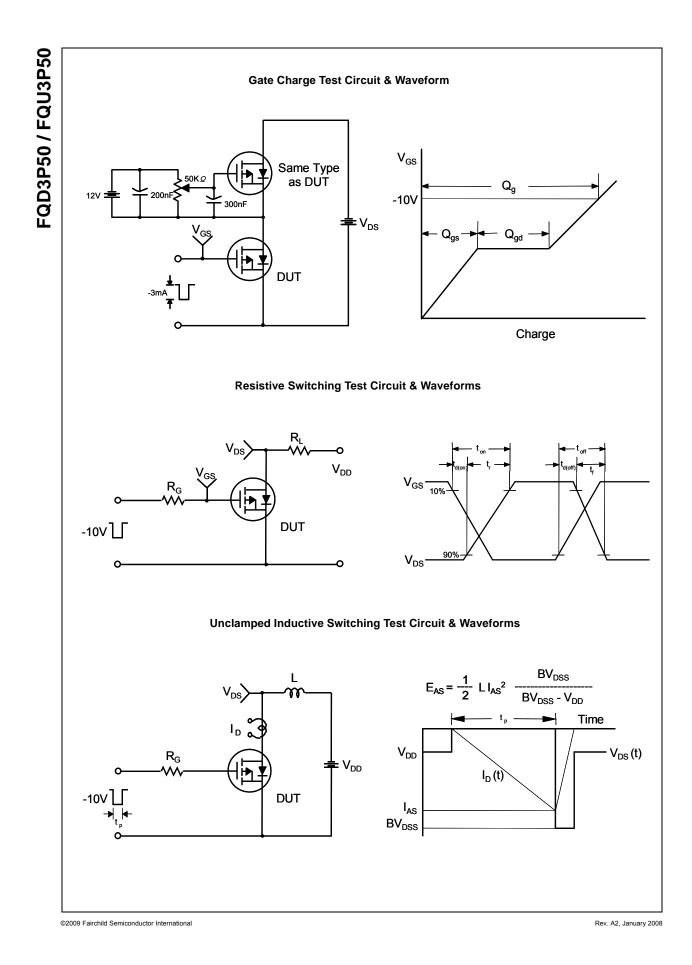
Off Char V _{DSS} BV _{DSS} ΔT _J		Test Conditions	Min	Тур	Max	Units
V _{DSS} BV _{DSS} J						
BV _{DSS} ΔT _J		V _{GS} = 0 V, I _D = -250 μA	500			N
v	Drain-Source Breakdown Voltage Breakdown Voltage Temperature	$V_{GS} = 0.0$, $I_D = -250 \mu\text{A}$ $I_D = -250 \mu\text{A}$, Referenced to 25°C	-500			V V/°C
~~	Coefficient			-		
SS	Zero Gate Voltage Drain Current	$V_{DS} = -500 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			-1	μA
		$V_{DS} = -400 \text{ V}, \text{ T}_{C} = 125^{\circ}\text{C}$			-10	μΑ
SSF	Gate-Body Leakage Current, Forward	$V_{GS} = -30 \text{ V}, V_{DS} = 0 \text{ V}$			-100	nA
SSR	Gate-Body Leakage Current, Reverse	V _{GS} = 30 V, V _{DS} = 0 V			100	nA
	racteristics				i	i
GS(th)	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = -250 \mu A$	-3.0		-5.0	V
DS(on)	Static Drain-Source On-Resistance	V _{GS} = -10 V, I _D = -1.05 A		3.9	4.9	Ω
s	Forward Transconductance	V _{DS} = -50 V, I _D = -1.05 A (Note 4)		2.1		S
ynamio	c Characteristics					
iss	Input Capacitance	V _{DS} = -25 V, V _{GS} = 0 V,		510	660	pF
oss	Output Capacitance	f = 1.0 MHz		70	90	pF
rss	Reverse Transfer Capacitance	-		9.5	12	pF
	Turn-On Delay Time	V _{DD} = -250 V, I _D = -2.7 A,		12	35	ns
(on)	Turn-On Rise Time	V_{DD} = -250 V, I _D = -2.7 A, R _G = 25 Ω		56	120	ns
(on) (off)	Turn-On Rise Time Turn-Off Delay Time	R _G = 25 Ω		56 35	120 80	ns ns
(on) (off)	Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time	R _G = 25 Ω (Note 4, 5)		56 35 45	120 80 100	ns ns ns
(on) (off) g	Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge	R_{G} = 25 Ω (Note 4, 5) V_{DS} = -400 V, I _D = -2.7 A,		56 35 45 18	120 80 100 23	ns ns ns nC
g gs	Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge	$R_{G} = 25 \Omega$ (Note 4, 5) V _{DS} = -400 V, I _D = -2.7 A, V _{GS} = -10 V	 	56 35 45 18 3.6	120 80 100 23 	ns ns nC nC
(on) (off) g gs	Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge	R_{G} = 25 Ω (Note 4, 5) V_{DS} = -400 V, I _D = -2.7 A,		56 35 45 18	120 80 100 23	ns ns ns nC
(on) (off) 9 gs gd	Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge	$R_{G} = 25 \Omega$ (Note 4, 5) V _{DS} = -400 V, I _D = -2.7 A, V _{GS} = -10 V (Note 4, 5)	 	56 35 45 18 3.6	120 80 100 23 	ns ns nC nC
(on) (off) 9 gs gd	Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge	$R_{G} = 25 Ω$ (Note 4, 5) $V_{DS} = -400 V, I_{D} = -2.7 A,$ $V_{GS} = -10 V$ (Note 4, 5) (Note 4, 5)	 	56 35 45 18 3.6	120 80 100 23 	ns ns nC nC
(on) (off) g gs gg gd rain-Sc	Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge Durce Diode Characteristics an Maximum Continuous Drain-Source Diode F	$R_{G} = 25 \Omega$ (Note 4, 5) $V_{DS} = -400 V, I_{D} = -2.7 A,$ $V_{GS} = -10 V$ (Note 4, 5) (Note 4,	 	56 35 45 18 3.6 9.2	120 80 100 23 	ns ns nC nC nC
(on) (off) g gg gg gd vrain-Sc M SD	Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge Durce Diode Characteristics an Maximum Continuous Drain-Source Diode F	$R_{G} = 25 \Omega$ (Note 4, 5) $V_{DS} = -400 V, I_{D} = -2.7 A,$ $V_{GS} = -10 V$ (Note 4, 5) (Note 4, 5	 	56 35 45 18 3.6 9.2	120 80 100 23 	ns ns nC nC nC
(on) (off) g gs gd vrain-Sc	Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge Durce Diode Characteristics an Maximum Continuous Drain-Source Diode F	$R_{G} = 25 \Omega$ (Note 4, 5) $V_{DS} = -400 V, I_{D} = -2.7 A,$ $V_{GS} = -10 V$ (Note 4, 5) (Note 4,	 	56 35 45 18 3.6 9.2	120 80 100 23 	ns ns nC nC nC A A



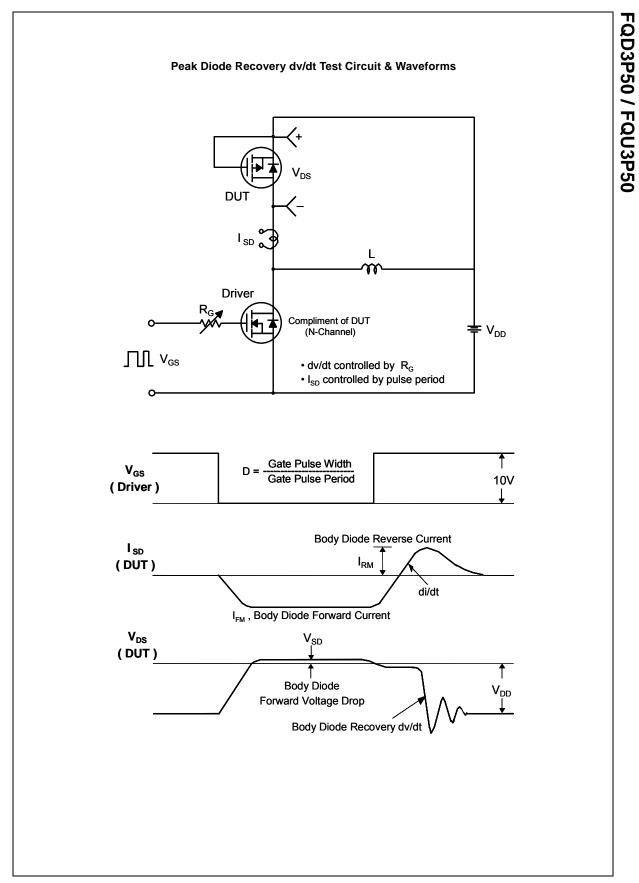




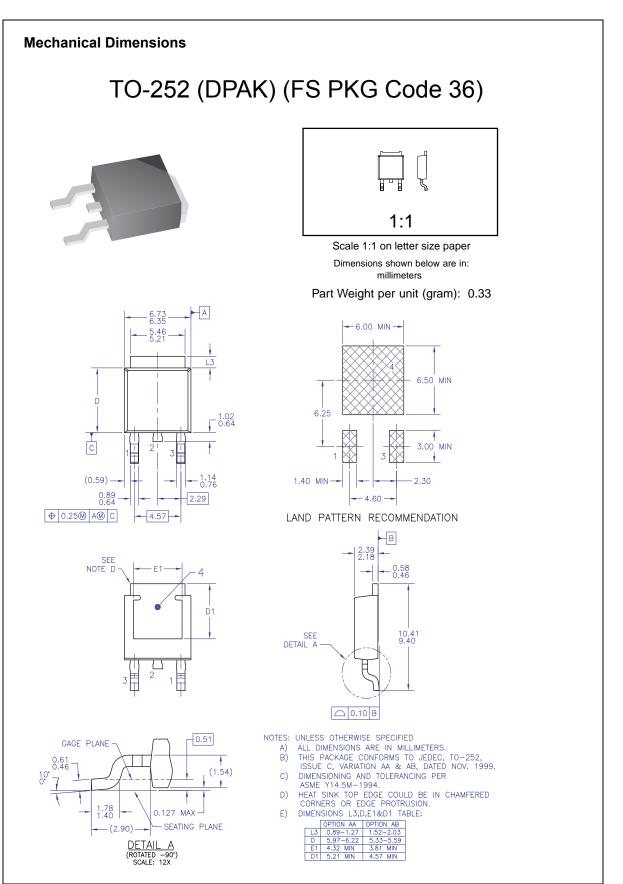
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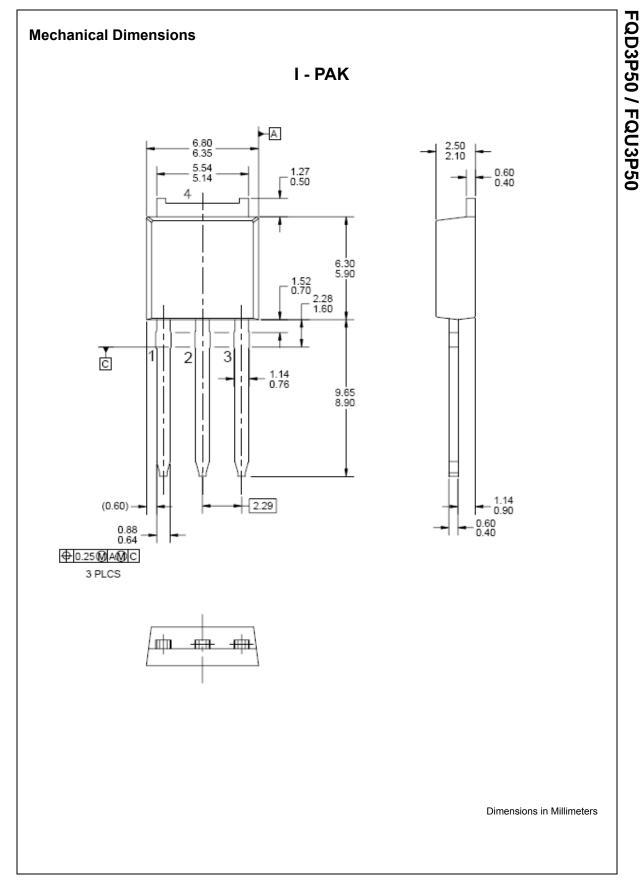


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